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# **Dual common source NPT IGBT Power Module**

C2

Q2

<sub>G2</sub>

E2 -O

C1

Q1

G1

 $\cap$ 

# $V_{CES} = 1200V$ $I_C = 100A$ (*a*) $T_C = 80^{\circ}C$

### Application

- AC Switches
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

### Features

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 50 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - Kelvin emitter for easy drive
  - Very low stray inductance
    - Symmetrical design
    - Lead frames for power connections
  - Internal thermistor for temperature monitoring
  - High level of integration

### Benefits

- Outstanding performance at high frequency • operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Easy paralleling due to positive TC of VCEsat
- Low profile
- **RoHS** compliant

# Absolute maximum ratings

CI

₿ E1

6

o

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1200	V
т	Continuous Collector Current	$T_c = 25^{\circ}C$	135	
1 <sub>C</sub>		$T_c = 80^{\circ}C$	100	А
I <sub>CM</sub>	Pulsed Collector Current	$T_c = 25^{\circ}C$	300	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_c = 25^{\circ}C$	568	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^{\circ}C$	200A @ 1200V	

🕅 A CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

E2 🕅 NTC2 G2 🛍 NTC1 0

C2

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Е



# All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

# **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Т	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_i = 25^{\circ}C$			350	μA
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{CE} = 1200V$	$T_{i} = 125^{\circ}C$			600	μΑ
N/	Callester Emitter Seturation Valtere	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		3.2	3.7	N/
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$I_{\rm C} = 100 {\rm A}$	$T_{j} = 125^{\circ}C$		4.0		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 2 \text{ mA}$		4.5		6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20 V, V_{CE} = 0V$				150	nA

# **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$			6900		
C <sub>oes</sub>	Output Capacitance				660		pF
C <sub>res</sub>	Reverse Transfer Capacitance				440		
Qg	Total gate Charge	$V_{GS} = 15V$			660		
Q <sub>ge</sub>	Gate – Emitter Charge	$V_{Bus} = 600V$			70		nC
Q <sub>gc</sub>	Gate – Collector Charge	$I_{\rm C} = 100 {\rm A}$			400		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switch		35			
Tr	Rise Time	$V_{GE} = 15V$			65		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$ $R_{G} = 2.5 \ \Omega$			320		ns
T <sub>f</sub>	Fall Time				30		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switch	ing (125°C)		35		
Tr	Rise Time	$V_{GE} = 15V$ $V_{Bus} = 600V$ $I_{C} = 100A$ $R_{G} = 2.5 \Omega$			65		
T <sub>d(off)</sub>	Turn-off Delay Time				360		ns
$T_{\rm f}$	Fall Time				40		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 600V$	$T_j = 125^{\circ}C$		13.9		T
E <sub>off</sub>	Turn-off Switching Energy	$I_{\rm C} = 100 \text{A}$ $R_{\rm G} = 2.5 \ \Omega$	$T_j = 125^{\circ}C$		6.1		mJ

# Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25^{\circ}C$			350	μA
IRM	Waxinium Reverse Leakage Current	v <sub>R</sub> -1200v	$T_j = 125^{\circ}C$			600	μА
I <sub>F</sub>	DC Forward Current		$Tc = 70^{\circ}C$		120		А
	Diode Forward Voltage	$I_{\rm F} = 120 {\rm A}$			2.0	2.5	
V <sub>F</sub>		$I_F = 240A$			2.3		V
		$I_{\rm F} = 120 {\rm A}$	$T_j = 125^{\circ}C$		1.8		
t	$t_{rr}$ Reverse Recovery Time $I_F = 120A$ $V_D = 800V$	$T_j = 25^{\circ}C$		370		na	
ι <sub>rr</sub>		$I_{\rm F} = 120 {\rm A}$ $V_{\rm R} = 800 {\rm V}$	$T_j = 125^{\circ}C$		500		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$di/dt = 800 \text{A}/\mu\text{s}$	$T_j = 25^{\circ}C$		2.64		μC
			$T_j = 125^{\circ}C$		13.8		μΟ



# Thermal and package characteristics

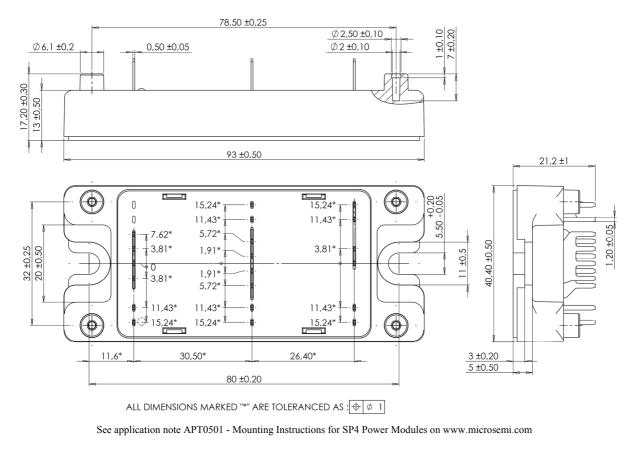
Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance	IGBT		0.22	°C/W		
<b>R</b> <sub>th</sub> JC	D		Diode			0.32	C/ W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T <sub>J</sub>	Operating junction temperature range			-40		150	
T <sub>STG</sub>	Storage Temperature Range		-40		125	°C	
T <sub>C</sub>	Operating Case Temperature -40 100						
Torque	Mounting torque	To heatsink	M5	2.5		4.7	N.m
Wt	Package Weight					160	g

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K
	D				

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### SP4 Package outline (dimensions in mm)





### **Typical Performance Curve**

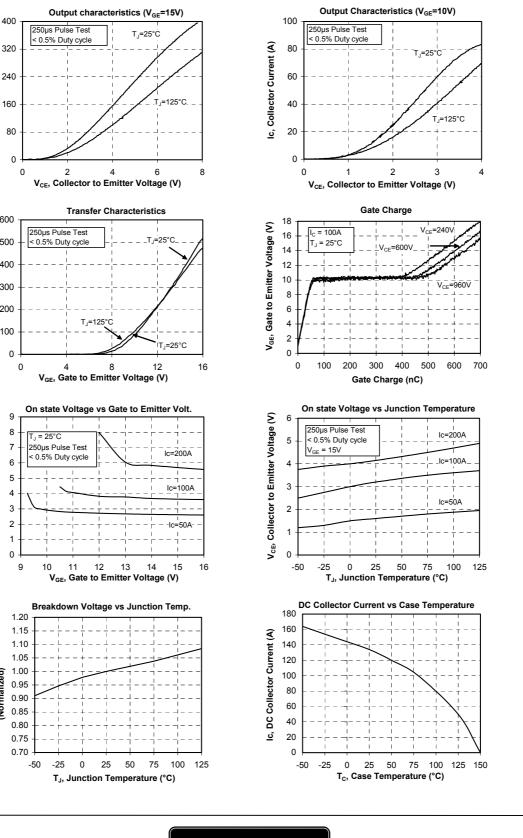
Ic, Collector Current (A)

V<sub>CE</sub>, Collector to Emitter Voltage (V)

**Collector to Emitter Breakdown Voltage** 

(Normalized)

Ic, Collector Current (A)



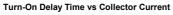
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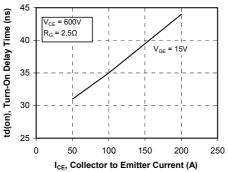
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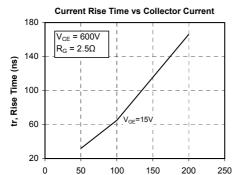
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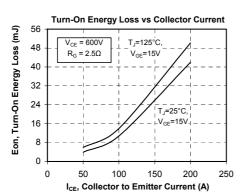




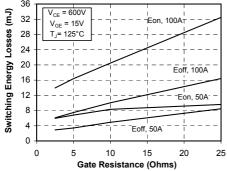




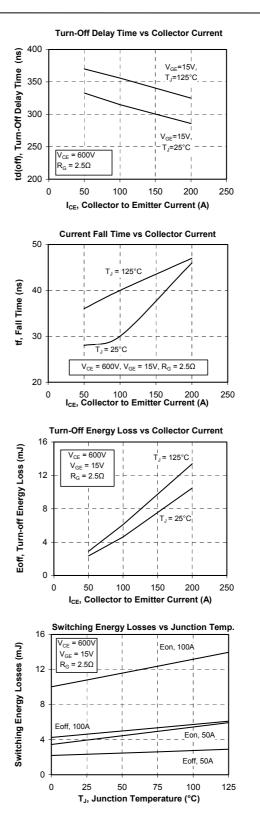
ICE, Collector to Emitter Current (A)



Switching Energy Losses vs Gate Resistance

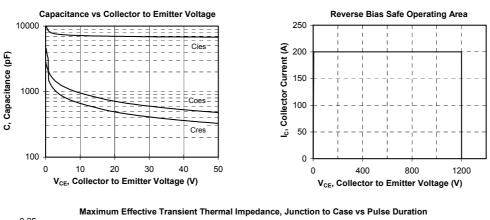


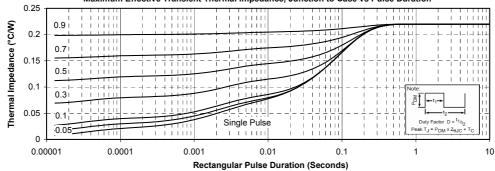
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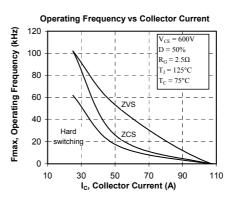


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